

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	8956	amplifier same quadrature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:27
L2	8572	I1 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:27
L3	31	I2 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 09:18
L4	678	amplifier same (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 09:25
L5	645	I4 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 09:18
L7	48	I5 and ((narrow adj bankd) narrow\$1band)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:37
L9	1	10/817090	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:47

L11	7	I5 and impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 08:05
L25	4584	(324/158.1.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 08:51
L26	21	I25 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 08:51
L27	397	(324/239.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 08:51
L28	6	I27 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 09:17
L29	592	vector adj modulator	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 09:17
L30	574	I29 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	ON	2005/05 09:18

L31	3	I30 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05 10:07
L33	6	I30 and (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 10:08
L34	3	I30 and amplifier same (quadrature adj (sens\$3 detect\$3))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 10:09
S1	43	(324/610.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05 07:25
S2	236	(324/609,602,600.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05 08:42
S3	2	jp-10038936-\$ did.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 08:35
S4	317	(324/525.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 09:07

S5	58	(324/123C.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 09:07
S6	176	(324/436,442.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 09:08
S7	356	(324/135,139,236.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:33
S8	829	(impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment)).ti.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 10:37
S9	708	S8 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 10:41
S10	5	S9 and automatic\$5 adj balanc\$5 adj (bridge link channel bus network connect\$5 line communicat\$5 interface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 10:58
S11	4396	(impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:55

S12	4166	S11 and @add<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 10:41
S13	8	S12 and automatic\$5 adj (bridge link channel bus network connect\$5 line communicat\$5 interface)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:06
S14	12	S12 and four\$2 adj (voltage current signal input stimul\$7 adj2 (source suppl\$5))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:16
S15	299	S12 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:39
S16	12	S14 and four\$2 adj (voltage current signal input stimul\$7 adj2 (source suppl\$5))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:18
S17	0	S16 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:48
S18	49	S15 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:45

S19	984	(324/649,650,691,713.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:53
S20	824	(327/100.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:54
S21	1499	(379/30,377,394,398.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:54
S22	246	(600/399,400,442.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:54
S23	1038	(600/506,547.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:55
S24	1028	(702/65,117.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:51
S25	87	S19 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:55

S26	1	S20 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:45
S27	22	S21 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:48
S28	2	S22 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:48
S29	232	S23 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 11:57
S30	28	S24 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:53
S31	21	S25 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:48
S32	4	S27 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:47

S33	10	S30 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:47
S34	5	S31 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:46
S35	0	S32 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:44
S36	1	S33 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:47
S37	33	S29 and ((sine adj (voltage current signal input stimul\$7 wave)) sine\$1voltage sine\$1current sine\$1signal sine\$1input sine\$1stimul\$7 sine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:49
S38	1	S37 and ((cosine adj (voltage current signal input stimul\$7 wave)) cosine\$1voltage cosine\$1current cosine\$1signal cosine\$1input cosine\$1stimul\$7 cosine\$1wave)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 12:48
S39	304	(702/107,198.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:56

S40	1003	(702/189-191.ccls.) and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:52
S41	4	S39 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:07
S42	5	S40 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7) adj (assembly unit system device apparatus machine mechanism section station means module set instrument tool circuit equipment))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:26
S43	9	S39 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:08
S44	14	S40 and (impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:08
S45	18121	impedance adj (check\$3 detect\$3 sens\$3 measur\$5 comput\$3 calculat\$3 \$2valuat\$3 examin\$5 test\$3 determin\$3 inspect\$3 monitor\$3 identif\$7)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 15:56
S46	17086	S45 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:06

S47	206	S46 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:06
S48	1	S47 and ((narrow adj bankd) narrow\$1band) adj2 amplif\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:06
S49	9	S47 and ((narrow adj bankd) narrow\$1band)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/05 07:37
S50	38	S46 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature same filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:09
S51	491	((narrow adj bankd) narrow\$1band) adj2 amplif\$5	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:06
S52	439	S51 and @ad<"20040402"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:06
S53	17	S52 and ((process\$5 conver\$5 modulat\$5) near3 (voltage current signal input stimul\$7 wave)) same quadrature same filter	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/04 16:09